

Cascadable Silicon Bipolar MMIC Amplifiers

Technical Data

MSA-0735, -0736

Features

- Cascadable 50 Ω Gain Block
- Low Operating Voltage: $4.0\,\mathrm{V}$ Typical V_d
- 3 dB Bandwidth: DC to 2.4 GHz
- 13.0 dB Typical Gain at 1.0 GHz
- Unconditionally Stable (k>1)
- Cost Effective Ceramic Microstrip Package

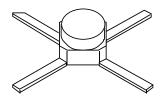
Description

The MSA-0735 is a high performance silicon bipolar Monolithic Microwave Integrated Circuit (MMIC) housed in a cost effective,

microstrip package. This MMIC is designed for use as a general purpose $50~\Omega$ gain block. Typical applications include narrow and broad band IF and RF amplifiers in industrial $\,$ and military applications.

The MSA-series is fabricated using HP's $10\,\mathrm{GHz}\,\mathrm{f_{T}},25\,\mathrm{GHz}\,\mathrm{f_{MAX}},$ silicon bipolar MMIC process which uses nitride self-alignment, ion implantation, and gold metallization to achieve excellent performance, uniformity and reliability. The use of an external bias resistor for temperature and current stability also allows bias flexibility.

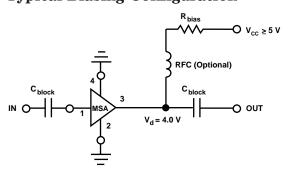
35 micro-X Package^[1]



Note:

 Short leaded 36 package available upon request.

Typical Biasing Configuration



5965-9591E 6-394

MSA-0735, -0736 Absolute Maximum Ratings

Parameter	Absolute Maximum ^[1]				
Device Current	60 mA				
Power Dissipation ^[2,3]	275 mW				
RF Input Power	+13dBm				
Junction Temperature	200°C				
Storage Temperature	−65 to 200°C				

Thermal Resistance $^{[2,5]}$:	
$\theta_{\rm jc} = 155$ °C/W	

Notes:

- 1. Permanent damage may occur if any of these limits are exceeded.
- 2. $T_{CASE} = 25$ °C.
- 3. Derate at 6.5 mW/°C for $T_{\rm C} > 157$ °C.
- 4. Storage above $+150^{\circ}\text{C}$ may tarnish the leads of this package making it difficult to solder into a circuit.
- 5. The small spot size of this technique results in a higher, though more accurate determination of θ_{jc} than do alternate methods. See MEASUREMENTS section "Thermal Resistance" for more information.

Electrical Specifications^[1], $T_A = 25^{\circ}C$

Symbol	Parameters and Test Conditions:	Units	Min.	Тур.	Max.	
GP	Power Gain ($ S_{21} ^2$)	f = 0.1 GHz	dB	12.5	13.5	14.5
$\Delta G_{ m P}$	Gain Flatness	f = 0.1 to 1.3 GHz	dB		± 0.6	± 1.0
f _{3 dB}	3 dB Bandwidth		GHz		2.4	
VCVVD	Input VSWR	f = 0.1 to 2.5 GHz			2.0:1	
VSWR	Output VSWR	f = 0.1 to 2.5 GHz			1.8:1	
NF	50Ω Noise Figure	f = 1.0 GHz	dB		4.5	
P _{1 dB}	Output Power at 1 dB Gain Compression	f = 1.0 GHz	dBm		5.5	
IP ₃	Third Order Intercept Point	f = 1.0 GHz	dBm		19.0	
t_{D}	Group Delay	f = 1.0 GHz	psec		140	
Vd	Device Voltage		V	3.6	4.0	4.4
dV/dT	Device Voltage Temperature Coefficient		mV/°C		-7.0	

Note:

Part Number Ordering Information

Part Number	No. of Devices	Container		
MSA-0735	10	Strip		
MSA-0736-BLK	100	Antistatic Bag		
MSA-0736-TR1	1000	7" Reel		

For more information, see "Tape and Reel Packaging for Semiconductor Devices".

^{1.} The recommended operating current range for this device is 15 to 40 mA. Typical performance as a function of current is on the following page.

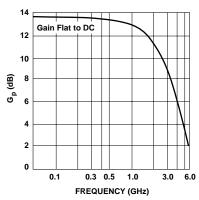
MSA-0735, -0736 Typical Scattering Parameters (Z $_{\rm O}$ = 50 $\Omega,\,T_{\rm A}$ = 25°C, $I_{\rm d}$ = 22 mA)

Freq.	S_{11}		\mathbf{S}_{21}		$\mathbf{S_{12}}$			\mathbf{S}_{22}		
GHz	Mag	Ang	dB	Mag	Ang	dB	Mag	Ang	Mag	Ang
0.1	.13	- 3	13.5	4.71	175	-19.0	.112	2	.29	- 7
0.2	.13	- 6	13.4	4.69	170	-18.5	.119	3	.29	-12
0.4	.14	-13	13.4	4.68	160	-18.6	.118	6	.29	- 24
0.6	.16	-20	13.3	4.64	150	-18.4	.120	7	.28	- 35
0.8	.19	– 29	13.2	4.60	140	-18.1	.125	8	.28	-4 7
1.0	.21	-4 0	12.9	4.42	129	-17.6	.131	10	.27	-58
1.5	.27	-7 1	12.2	4.07	104	-16.5	.149	10	.24	– 83
2.0	.32	-107	11.5	3.74	79	-15.6	.165	7	.19	-103
2.5	.37	-134	10.3	3.26	62	-15.3	.173	5	.15	- 113
3.0	.43	-160	8.8	2.76	44	-15.4	.171	0	.14	-120
3.5	.47	-179	7.5	2.37	27	-15.3	.173	-4	.16	- 120
4.0	.49	167	6.2	2.05	12	-15.2	.168	- 6	.21	- 121
5.0	.51	134	4.0	1.59	-15	-15.2	.173	-11	.28	- 135
6.0	.60	96	2.1	1.27	-4 2	-14.6	.185	-16	.29	-167

A model for this device is available in the DEVICE MODELS section.

Typical Performance, $T_A = 25^{\circ}C$

(unless otherwise noted)



 $\begin{array}{l} Figure \ 1. \ Typical \ Power \ Gain \ vs. \\ Frequency, \ I_d = 22 \ mA. \end{array}$

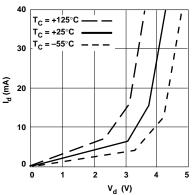


Figure 2. Device Current vs. Voltage.

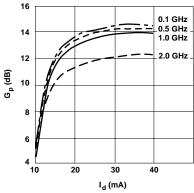


Figure 3. Power Gain vs. Current.

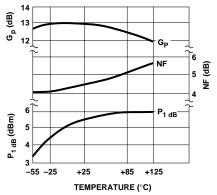


Figure 4. Output Power at 1 dB Gain Compression, NF and Power Gain vs. Case Temperature, $f=1.0~\mathrm{GHz},$ $I_d=22\mathrm{mA}.$

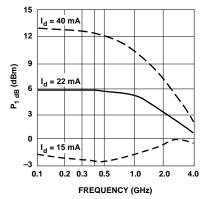


Figure 5. Output Power at 1 dB Gain Compression vs. Frequency.

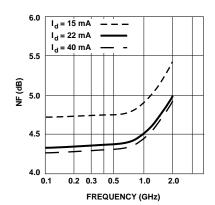


Figure 6. Noise Figure vs. Frequency.

35 micro-X Package Dimensions

